

Application/Control	No.
10/602,910	

Examiner
David M. Naff

Applicant(s)/Patent under Reexamination
TAKAYAMA ET AL.

Art Unit 1657

	INTERNATIONAL CLASSIFICATION											
CLASS SUBCLASS						CL	AIMED	NON-CLAIMED				
	395	С	12	N	5	/00						
	С	12	Q	1	/00							
CLASS	SUBCLASS (	ONE SUBCLASS	PER BLOCK)				<u> </u>					
435	4			С	12	Q	1	/02		1		
435	29			С	12	N	11	/00		1		
435	174			С	07	к	17	/08		1		
530	811			С	07	к	17	/14				
530	815							1		1		

(Assistant Examiner) (Date)

David M. Naff 2

Naff 2/28/07

(Date)

(Primary Examiner)

Total Claims Allowed: 14

O.G. Print Claim(s)

O.G. Print Fig. None

	Claims renumbered in the same order as presented by applicant									□ c	PA		☐ T.D.			☐ R.1.47			
Final	Original		Final	Original		Final	Original		Final	Original	-4.	Final	Original		Final	Original		Final	Original
	4		7	31			61			91			121			151			181
	2	1	8	32			62	1		92		_	122			152			182
	3	١.	9	33			63	1		93			123	i		153			183
	4		10	34	١.		64	1		94			124			154			184
	5		11	35			65			95	, p		125	-		155	*		185
	6	l ·	12	36			66	1		96			126			156			186
	7	1	13	37			67	]		97			127			157			187
	8	1	14	38_			68	]		98			128			158			188
	9			39			69	1		99			129			159			189
	10			40			70			100			130			160			190
	11			41			71			101			131			161			191
	12			42			72			102			132			162			192
	18			43			73	]		103			133		•	163			193
	14			44			74			104			134			164			194
	15			45			75			105			135			165			195
	16			46			76	1		106			136			166			196
	17			47			77	]		107			137			167			197
	18			48			78	]		108			138			168			198
	19			49			79			109			139			169			199
	20			50			80	]		110			140			170			200
	2			51			81	]		111			141			171			201
	22			52			82	]		112			142			172			202
	2β	Ì		53			83	]		113			143			173			203
	24			54			84	]		114			144			174			204
1	25			55			85			115			145			175			205
2	26			56			86	]		116			146			176			206
3	27			57			87			117			147			177			207
4	28			58			88			118			148			178			208
5	29			59			89			119			149			179			209
6	30			60			90			120			150			180			210